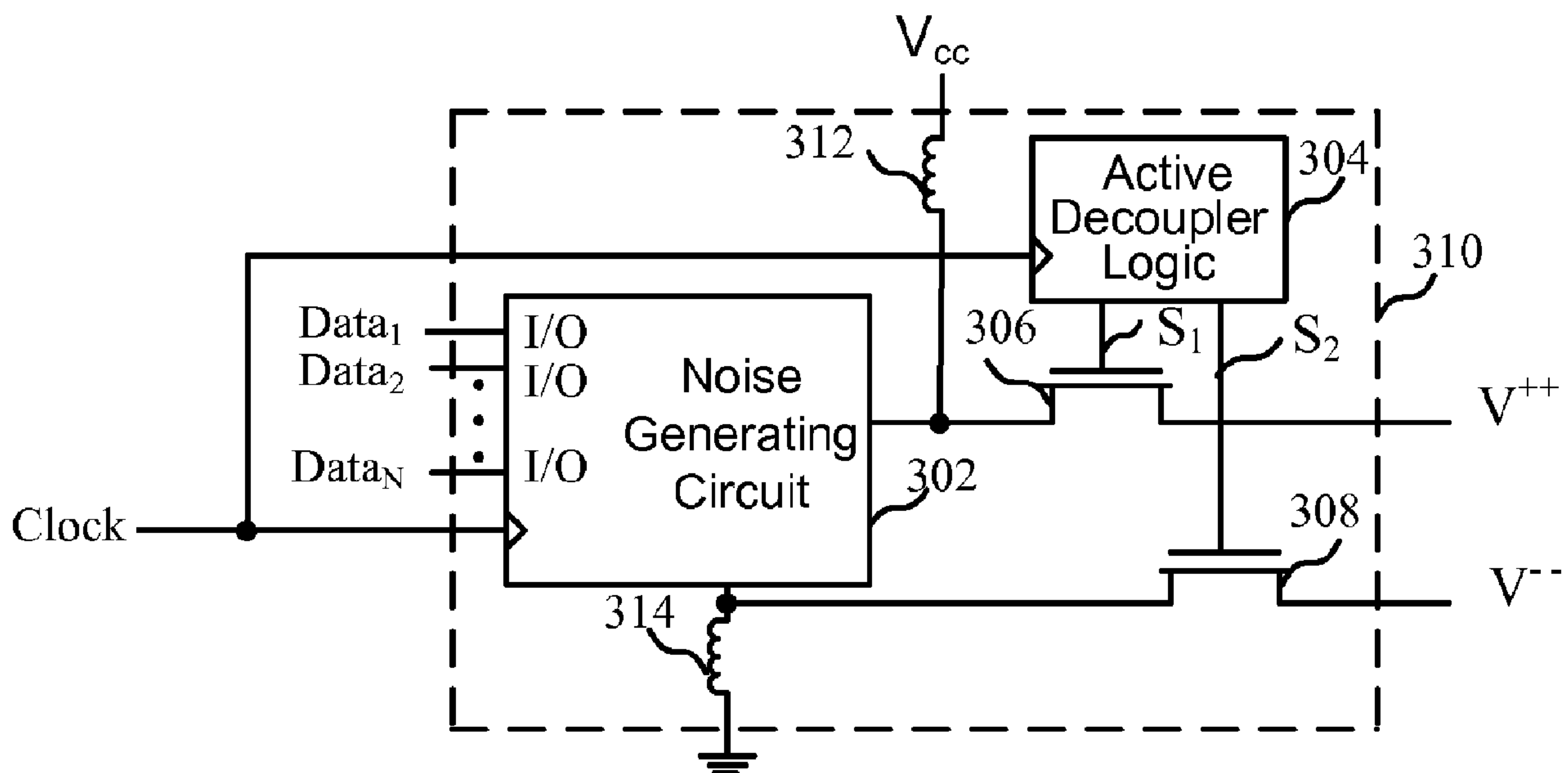




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(54) Title: METHOD OF AND CIRCUIT FOR SUPPRESSING NOISE IN A CIRCUIT



(57) Abrégé/Abstract:

A method of suppressing noise in a circuit (302) is disclosed. The method comprises providing a supply voltage (V_{cc}) to a first terminal (312) of the circuit; (302) providing a ground voltage to a second terminal (314) of the circuit; providing a clock signal to the circuit; and actively decoupling noise from at least one of the first terminal (312) and the second terminal (314) of the circuit (302) by actively decoupling noise synchronously with the clock signal. A circuit for suppressing noise in a circuit (302) is also disclosed.

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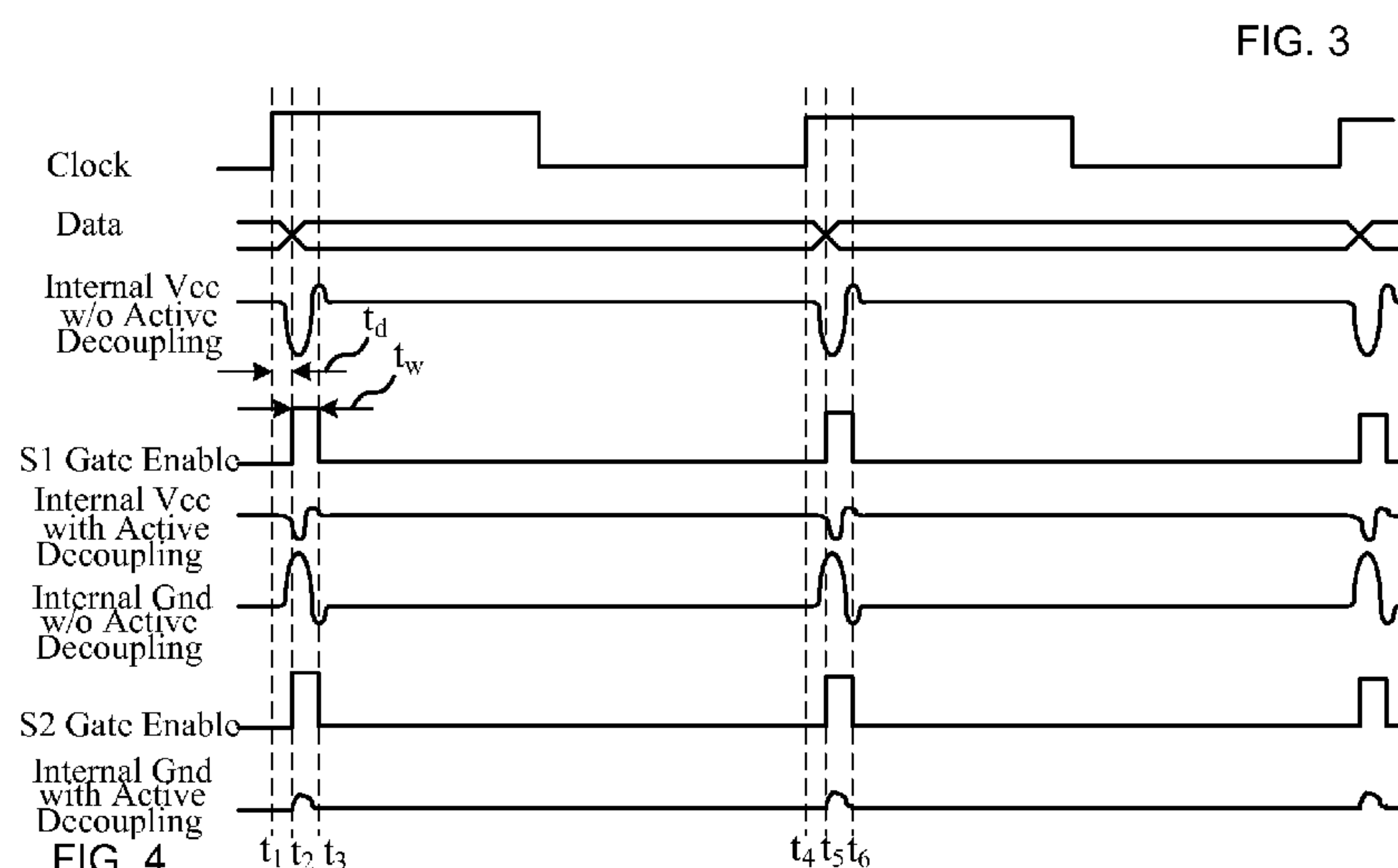
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(54) Title: METHOD OF AND CIRCUIT FOR SUPPRESSING NOISE IN A CIRCUIT



(57) Abstract: A method of suppressing noise in a circuit (302) is disclosed. The method comprises providing a supply voltage (Vcc) to a first terminal (312) of the circuit; (302) providing a ground voltage to a second terminal (314) of the circuit; providing a clock signal to the circuit; and actively decoupling noise from at least one of the first terminal (312) and the second terminal (314) of the circuit (302) by actively decoupling noise synchronously with the clock signal. A circuit for suppressing noise in a circuit (302) is also disclosed.

METHOD OF AND CIRCUIT FOR SUPPRESSING NOISE IN A CIRCUIT

FIELD OF THE INVENTION

The present invention relates generally to integrated circuits, and in
5 particular, to a method of and circuit for suppressing noise in a circuit.

BACKGROUND OF THE INVENTION

Integrated circuit devices typically have a number of input/output pins to
generate output signals. Output signals of an integrated circuit are typically
switched simultaneously in response to a clock signal. Such simultaneously
10 switching of outputs results in large transient currents which are often difficult to
control. In particular, power and ground noise, which comprises undesirable
signals on a line, is generated in on-chip power and ground buses when the
signals at the outputs switch logic states simultaneously. When a significant
number of drivers switch at the same time, an increased current draw on the
15 power supply may cause a droop or negative spike in the voltage supply to the
chip. This dip in power supply voltage may propagate as noise through both
active and quiet drivers, and may cause false switching in the system. With
system speeds increasing and the demands to transmit more data, destructive
switching noise has become a significant concern.

20 Jitter in a clock signal, caused by thermal noise or external interference
through the power or ground lines may also have a significant impact on the
operation of a circuit. For example, period jitter, also known as “edge-to-edge”
jitter, is the deviation in time of any clock period from the ideal clock period.
Period jitter results in phase variations with respect to a perfect reference clock
25 or data signal as a result of noise. The period jitter is usually measured as the
difference between the longest period and the shortest period. Accommodating
for period jitter is necessary to ensure that there is adequate setup time for all of
the signals. Jitter may also arise from simultaneous switching of internal logic
that are not part of the input/output (I/O) elements, such as configurable logic
30 blocks (CLBs) or blocks of Random Access Memory (BRAMs) of a
programmable logic device (PLD), which will be described in more detail below.
Accordingly, it is necessary to overcome large transients resulting from

simultaneous switching noise or thermal noise resulting in clock jitter, and provide noiseless power and ground connections.

Supply noise suppression has been done in conventional circuits with passive components, such as capacitors connected across the power supply rail and ground. The capacitor provides a shunt path for transient noise on the supply rail to ground to minimize transient voltage amplitude, while storing and providing a local charge to minimize voltage droop. However, the performance of passive devices is limited by their parasitic inductance, series resistance, and capacitance which are functions of the type of material used, packaging, temperature, DC bias, and operating frequency. Further, because a capacitor becomes inductive past its resonant frequency, a given capacitor value is typically optimal for one resonant frequency, but not over a wide range of frequencies. In addition, due to parasitic resistance and inductance, the performance of passive devices tends to degrade rapidly at frequencies above 100Mhz.

Accordingly, there is a need for an improved method of and circuit for suppressing noise in a circuit.

SUMMARY OF THE INVENTION

A method of suppressing noise in a circuit is disclosed. The method comprises providing a supply voltage to a first terminal of the circuit; providing a ground voltage to a second terminal of the circuit; providing a clock signal to the circuit; and actively decoupling noise from at least one of the first terminal and the second terminal of the circuit by actively decoupling noise synchronously with the clock signal. Actively decoupling noise may comprise shunting the first terminal of the circuit to a voltage greater than the supply voltage and/or shunting the second terminal of the circuit to a voltage less than ground. An offset from the clock signal may also be provided for actively decoupling noise, which may be performed during a predetermined portion of the clock period.

According to an alternate embodiment, a method of suppressing noise in a circuit comprises providing a supply voltage to a first terminal of the circuit; providing a ground voltage to a second terminal of the circuit; and actively decoupling noise from at least one of the first terminal or the second terminal of the circuit by selectively shunting at least one of the first terminal or the second terminal to a voltage having a greater magnitude during switching of a signal at

an output. The method may further comprise providing a clock signal to the circuit, wherein active decoupling noise comprises decoupling noise synchronously with the clock signal. Further, actively decoupling noise may comprise shunting the first terminal to a voltage greater than the supply voltage
5 and shunting the second terminal to a voltage less than ground.

A circuit for suppressing noise at a terminal is also disclosed. The circuit comprises a clock signal coupled to a clock input; a supply voltage coupled to a first terminal; a ground voltage coupled to a second terminal; and a switching circuit coupled to at least one of the first terminal and the second terminal to
10 actively decoupling noise from the first terminal or the second terminal of the circuit by actively decoupling noise synchronously with the clock signal. The device may further comprise a first switch coupled between the first terminal and a voltage which is greater than the supply voltage and a second switch coupled between the second terminal and a voltage which is less than ground. A
15 programmable pulse generator for adjusting the phase and pulse width of a pulse for decoupling noise synchronously with the clock signal may also be provided.

BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a block diagram of a circuit for suppressing noise according to an
20 embodiment the present invention;

Fig. 2 is a block diagram of an integrated circuit package having a circuit for suppressing noise according to an embodiment of the present invention;

Fig. 3 is a block diagram of a circuit for suppressing noise according to an alternate embodiment of the present invention;

25 Fig. 4 is a timing diagram showing the operation of the circuits of Figs. 1-3 according to an embodiment of the present invention;

Fig. 5 is a block diagram of a circuit having a capacitor for suppressing noise at a voltage supply according to an embodiment of the present invention;

Fig. 6 is a block diagram of a circuit for suppressing noise in a device having a
30 plurality of supply voltages according to an embodiment of the present invention;

Fig. 7 is a circuit of the active decoupler logic for generating gate control signals according to an embodiment of the present invention;

Fig. 8 is a block diagram of a programmable logic device according to an embodiment of the present invention; and

Fig. 9 is a flow chart showing a method of suppressing noise according to an embodiment the present invention.

DETAILED DESCRIPTION OF THE DRAWINGS

Turning first to Fig. 1, a block diagram of a circuit for suppressing noise according to an embodiment the present invention is shown. In particular, a noise generating circuit 102 is coupled to receive a supply voltage V_{cc} and a clock signal, and is coupled to a ground voltage. According to the embodiment of Fig. 1, the circuit is also coupled to receive a first voltage, called a highly positive voltage V^{++} , which is a voltage that is greater than V_{cc} , and second voltage, called a highly negative V^{--} , which is a voltage that is less than ground. By way of example, for a 2.5 volt V_{cc} , V^{++} may be 3.3 volts and V^{--} may be -1.2 volts. An active decoupling circuit 104 comprises active decoupler logic 106 which generates control signals S1 and S2 to control switches 108 and 110, respectively. The active decoupler logic is coupled to receive the clock signal and preferably comprises a pulse width generator circuit to generate the appropriate control signals S1 and S2. As will be described in more detail below, the use of active devices, such as switches 108 and 110, for selectively coupling V^{++} and V^{--} to the circuit in response to control signal S1 and S2 provides improved suppression of noise on the power and ground terminals.

Accordingly, a voltage having a greater magnitude is coupled to the supply voltage and ground voltage, where a voltage having a more positive value than the supply voltage is applied to the supply terminal and a voltage having a more negative value than ground is applied to the ground terminal. A voltage having a greater magnitude may be applied to either the supply voltage, the ground voltage or both. Unlike passive devices, active de-couplers shunt the noisy supply voltage to a clean and stable alternate local voltage reference for a finite amount of time to suppress the ripple present on the noisy supply. The clean power supply provides a large local supply of charge so to minimize voltage droop, and the low-ripple supply voltage reference that serves to stabilize the noisy supply. The switches enabling active decoupling may be low on-resistance transistors, typically 0.001 ohm or less, for example, that are controlled by a pulse generator circuit which determines when the transistors are turned on or off. The generation of the pulses for controlling the switches will be described in more detail in reference to Figs. 4-7.

According to one embodiment of the invention shown in the block diagram of Fig. 2, an integrated circuit package 200 comprises a die 202 on a substrate 204 which is coupled to receive the V^{++} and V^{--} voltages. As shown in the embodiment of Fig. 2, the package is also coupled to receive the clock signal, V_{cc} , and ground at various terminals of the substrate. According to one embodiment, the noise generating circuit 102, the active decoupler logic 106, and the switches 108 and 110 may be implemented on the die 202. Alternatively, the noise generating circuit 102 may be implemented on the die 202, while the switches 108 and 110 may be implemented as discrete components on the substrate 204. As will be described in more detail in reference to Fig. 3, the noise generating circuit 102 and the switches 108 and 110 may be distributed over different elements of an electronic device, such as a printed circuit board.

Turning now to Fig. 3, a noise generating circuit 302, active decoupler logic 304 and switches comprising transistors 306 and 308 may be distributed over various components of a device 310. In the embodiment of Fig. 3, V^{++} is selectively coupled to the noise generating circuit 302 of a device 310 by transistor 306 having a gate controlled by a control signal S_1 from the active decoupler logic 304. Similarly, V^{--} is selectively coupled to the circuit by a transistor 308 having a gate controlled by a control signal S_2 . While the control signals S_1 and S_2 as shown are provided from the active decoupler logic 304 by way of example, the active decoupler logic 304 and/or the transistors 306 and 308 may be a part of the noise generating circuit 302. The parasitic inductance of the leads of the transistors at the V_{cc} and ground nodes, which may vary depending upon the implementation of the device 310, is shown by inductors 312 and 314. Although metal oxide semiconductor circuits are shown by way of example, other types of transistors or switches could be employed according to the present invention. The noise generating circuit 302 may be incorporated as part of a microprocessor, a programmable logic device (PLD), an application specific integrated circuit (ASIC), a gate array, or any general-purpose design based on integrated circuit technology, or a printed circuit board implementing any of these devices coupled to transistors 306 and 308. For example, the noise generating circuit 302 may be implemented in silicon embedded in an integrated circuit, and the transistors implemented in discrete logic on a printed circuit

board. Alternatively, all of the elements of the device 310 may also be implemented as stand-alone devices used to decouple noise or suppress electro-magnetic radiated emissions in a digital, analog, or similar system. As will be described in more detail below in reference to Fig. 4, an active decoupling
5 circuit, comprising the active decoupler logic 304 and the transistors 306 and 308, offers stable inductance and resistance over a wide range of operating frequencies and over a wide range of temperatures and voltages, and suppresses transient noise consistently over a wide operating frequency range.

Turning now to Fig. 4, a timing diagram shows the operation of the circuits of
10 Figs. 1-3. After a rising edge of the clock signal at a time t_1 , data is latched at a terminal of the device, such as an input/output (I/O) pin of the device, at a time t_2 . A pulse generator of the active decoupler logic 304, described in more detail in reference to Fig. 7, is referenced to the same clock that is used to drive switching logic of the noise generating circuit 302. However, the gate enable
15 signal S1 may be delayed by a delay period t_d until a time t_2 . That is, any voltage droop of the supply voltage or spike in the ground voltage may be delayed because of circuit skew in the circuit, as is well known in the art. Accordingly, after the delay is determined, the delay period t_d is set by the pulse generator to generate the pulse at time t_2 . Similarly, the pulse width t_w is determined
20 depending upon duration of the droop or spike. The delay period t_d and the pulse width t_w comprising a predetermined portion of the clock period may vary depending upon a number of factors, including the type of device used and the circuit employed in the device. Accordingly, the delay period t_d and pulse width t_w are determined through testing and analysis of the device and circuit which is
25 implemented in the device.

As shown in Fig. 4, the droop of the V_{cc} signal for the circuit is significantly greater during the period between t_2 and t_3 without active decoupling than with active decoupling where the V^{++} signal is coupled to V_{cc} through switch 306. Similarly, the S_2 gate enable pulse causes the V^{--} to be coupled to the ground
30 voltage, where the bounce on the ground rail is significantly less during the period between t_2 and t_3 than without the application of V^{--} to the ground terminal. Because devices implementing the circuit of Figs. 1-3 track the clock that drives switching logic, they are able to synchronously suppress switching transient noise that is generated coincidentally with that clock. That is, the noise

is decoupled synchronously with the clock signal based upon one or more signals which may be offset by a delay and have a predetermined pulse width. Further, the circuits of Figs. 1-3 provide a new class of "active decoupling" devices having very low fixed inductance and resistance that perform well over a wide range of frequencies. Although the timing diagram in Fig. 4 is shown relative to the rising edge of the clock by way of example, the active decoupler could be designed to work with the falling edge of the clock, or with both clock edges.

Turning now to Fig. 5, a block diagram of a circuit having a capacitor for suppressing noise at a voltage supply according to an alternate embodiment of the present invention is shown. The circuit of Fig. 5 is similar to the circuit of Fig. 3 except that an additional transistor 502 is coupled to the transistor 306, and a capacitor 504 is coupled at the node coupling the transistors 502 and 306. An inverter 506 is coupled to receive the control signal which controls transistor 306 and to generate an inverted signal to control the transistor 502. As can be seen, V^{++} is used to pre-charge the capacitor 504 when transistor 502 is on and transistor 306 is off. When the additional voltage is necessary to be applied to V_{cc} , transistor 306 is turned on and transistor 502 is turned off. Accordingly, the charge on the capacitor is used to provide the additional charge necessary to prevent voltage droop in the supply voltage V_{cc} . Although an inverter is shown by way of example, other devices may be used to control the gate of the transistor 502, or signals which are generated independently may be employed to control the transistors 306 and 502.

Turning now to Fig. 6, a block diagram of a circuit for suppressing noise in a device having a plurality of supply voltages according to an embodiment of the present invention is shown. As shown in the circuit of Fig. 6, a device 602, such as an integrated circuit or printed circuit board, may comprise a plurality of supply voltages, shown here as $V_{cc1} - V_{ccN}$. Each supply voltage may be coupled to a greater voltage to prevent droop in the supply voltage as described above. In particular, the supply voltages $V_{cc1} - V_{ccN}$ may be coupled to a voltages $V^{++1} - V^{++N}$, respectively. A plurality of switches may be employed in the paths between the supply voltage and the corresponding greater voltage. For example, a capacitor 604 may be coupled to a node between a first switch S_1 and a second switch $/S_1$. Voltage droop may be avoided in the supply voltage as

described above with respect to Fig. 5 by selectively charging the capacitor to a voltage greater than the supply voltage, and coupling the capacitor to the supply voltage during switching. Capacitors 606-610 may also be coupled to nodes between first and second switches associated with supply voltages $V_{cc2} - V_{ccN}$,
5 respectively. Finally, a switch 612 may be used to couple ground to a greater negative voltage to prevent ground bounce, as described above. Although only one ground and one switch 612 are shown, additional switches could be employed for other isolated grounds on the same device. The circuit of Figs. 1-6 may be used either as stand alone or in conjunction with passive decoupling
10 devices, such as decoupling capacitors.

Turning now to Fig. 7, a circuit of the active decoupler logic for generating gate control signals according to an embodiment of the present invention is shown. In particular, a clock synthesizer 702 receives a clock signal, and generates a clock signal which is coupled to a programmable phase shifter 704.
15 The programmable phase shifter 704 will generate a phase shifted clock signal which is shifted based upon the time delay t_d . The phase shifted clock signal is coupled to a programmable pulse width generator 706 which generates a pulse starting at the rising edge of the phase shifted clock signal and ending after a predetermined pulse width. As described above, the pulse width represents the
20 approximate duration t_w of the voltage droop or ground bounce, and is determined based upon the device being used and the circuit which is employed. The programmable pulse width generator may consist of a Delay Locked Loop (DLL) or similar clock recovery circuitry, a fixed or variable delay element, a self-timing element, or other gating logic. As shown, each of the separate gate
25 control signals $S_1 - S_N$ may be generated separately.

Turning now to Fig. 8, a block diagram of a programmable logic device according to an embodiment of the present invention is shown. A programmable logic device is one type of integrated circuit which is designed to be user-programmable so that users may implement logic designs of their choices. One
30 type of programmable logic device is the Complex Programmable Logic Device, or CPLD. A CPLD includes two or more "function blocks" connected together and to input/output (I/O) resources by an interconnect switch matrix. Each function block of the CPLD includes a two-level AND/OR structure similar to that used in a Programmable Logic Array (PLA) or a Programmable Array Logic

(PAL) device. Another type of programmable logic device is a field programmable gate array (FPGA). In a typical FPGA, an array of configurable logic blocks (CLBs) is coupled to programmable input/output blocks (IOBs). The CLBs and IOBs are interconnected by a hierarchy of programmable routing
5 resources.

Fig. 8 shows an FPGA architecture 800 which includes a large number of different programmable tiles including multi-gigabit transceivers (MGTs 801), configurable logic blocks (CLBs 802), random access memory blocks (BRAMs 803), input/output blocks (IOBs 804), configuration and clocking logic
10 (CONFIG/CLOCKS 805), digital signal processing blocks (DSPs 806), specialized input/output blocks (I/O 807) (e.g., configuration ports and clock ports), and other programmable logic 808 such as digital clock managers, analog-to-digital converters, system monitoring logic, and so forth. Some FPGAs also include dedicated processor blocks (PROC 810). The active
15 decoupling circuits of Figs. 1-3 and 5-6 may be implemented in the FPGA, or coupled to a supply voltage pin and ground pin of the FPGA, as described above.

In some FPGAs, each programmable tile includes a programmable interconnect element (INT 811) having standardized connections to and from a
20 corresponding interconnect element in each adjacent tile. Therefore, the programmable interconnect elements taken together implement the programmable interconnect structure for the illustrated FPGA. The programmable interconnect element (INT 811) also includes the connections to and from the programmable logic element within the same tile, as shown by the
25 examples included at the top of Fig. 8.

For example, a CLB 802 may include a configurable logic element (CLE 812) that may be programmed to implement user logic plus a single programmable interconnect element (INT 811). A BRAM 803 may include a BRAM logic element (BRL 813) in addition to one or more programmable interconnect
30 elements. The BRAM comprises dedicated memory separate from the distributed RAM of a configuration logic block. Typically, the number of interconnect elements included in a tile depends on the height of the tile. In the pictured embodiment, a BRAM tile has the same height as four CLBs, but other numbers (e.g., five) may also be used. A DSP tile 806 may include a DSP logic

element (DSPL 814) in addition to an appropriate number of programmable interconnect elements. An IOB 804 may include, for example, two instances of an input/output logic element (IOL 815) in addition to one instance of the programmable interconnect element (INT 811).

5 In the pictured embodiment, a columnar area near the center of the die (shown shaded in Fig. 8) is used for configuration, clock, and other control logic. Horizontal areas 809 extending from this column are used to distribute the clocks and configuration signals across the breadth of the FPGA. Some FPGAs utilizing the architecture illustrated in Fig. 8 include additional logic blocks that
10 disrupt the regular columnar structure making up a large part of the FPGA. The additional logic blocks may be programmable blocks and/or dedicated logic. For example, the processor block PROC 810 shown in Fig. 8 spans several columns of CLBs and BRAMs.

Note that Fig. 8 is intended to illustrate only an exemplary FPGA architecture.
15 The numbers of logic blocks in a column, the relative widths of the columns, the number and order of columns, the types of logic blocks included in the columns, the relative sizes of the logic blocks, and the interconnect/logic implementations included at the top of Fig. 8 are purely exemplary. For example, in an actual FPGA more than one adjacent column of CLBs is typically included wherever the
20 CLBs appear, to facilitate the efficient implementation of user logic. While an FPGA is shown in detail as one type of programmable logic device by way of example, the circuits and methods of the present invention may be implemented in any device, including any type of integrated circuit having programmable logic.

Turning now to Fig. 9, a flow chart shows a method of suppressing noise
25 according to an embodiment the present invention. In particular, a supply voltage is provided to a first terminal of the circuit at a step 902. A ground voltage is provided to a second terminal of the circuit at a step 904. An offset period from the clock signal is determined for actively decoupling noise at a step 906. A predetermined portion of the clock period is determined for actively
30 decoupling the noise at a step 908. Noise is actively decoupled from the first terminal of the circuit by shunting the first terminal of the circuit to a voltage greater than the supply voltage during the predetermined period after the offset period at a step 910. Noise is actively decoupled from the second terminal of the circuit by shunting the second terminal of the circuit to a voltage less than ground

during the predetermined period after the offset period at a step 912. The method of Fig. 9 may be implemented using any of the circuits of Figs. 1-3 and 5-6 as described above, or any other suitable circuit.

It can therefore be appreciated that a novel method of and circuit for
5 suppressing noise has been described. The invention described above is a new method to suppress power supply noise in a digital or analog switching system. The active decoupling method and circuit described above uses circuitry that suppresses transient voltage droop and ripple that are generated by switching logic. It offers fixed parasitic inductance and resistance over a wide temperature,
10 voltage, and frequency range. While the circuits described above are shown by way of example, the circuits and methods could be implemented with any type of circuit or device to avoid voltage droop or bounce. It will be appreciated by those skilled in the art that numerous alternatives and equivalents will be seen to exist which incorporate the disclosed invention. As a result, the invention is not to be
15 limited by the foregoing embodiments, but only by the following claims.

CLAIMS

What is claimed is:

- 5 1. A method of suppressing noise in a circuit, the method comprising:
- providing a supply voltage to a first terminal of the circuit;
- providing a ground voltage to a second terminal of the circuit; and
- 10 providing a clock signal to the circuit;
- actively decoupling noise from at least one of the *first* terminal and the second terminal of the circuit by actively decoupling noise synchronously with the clock signal,
- 15 wherein actively decoupling noise comprises shunting the first terminal of the circuit to a voltage greater than the supply voltage, and shunting the second terminal of the circuit to a voltage less than ground.
- 20 2. The method of claim 1 wherein actively decoupling noise comprises providing a pulse that is delayed based on a circuit skew in the circuit, wherein a width of the pulse depends on a duration of a droop of the supply voltage or a spike in the ground voltage.
3. The method of claim 1 wherein actively decoupling noise comprises actively decoupling
- 25 noise during a predetermined portion of the clock period.
4. The method of claim 1 further comprising charging a capacitor to a predetermined voltage greater than the supply voltage, wherein actively decoupling noise comprises shunting the first terminal to the capacitor.
- 30 5. A circuit for suppressing noise at a terminal, the circuit comprising:
- a clock signal coupled to a clock input;
- 35 a supply voltage coupled to a first terminal;

a ground voltage coupled to a second terminal; and

5 a switching circuit coupled to at least one of the first terminal and the second terminal to actively decouple noise from the at least one of the first terminal and the second terminal of the circuit by actively decoupling noise synchronously with the clock signal,

10 wherein actively decoupling noise comprises coupling a first switch between the first terminal and a voltage which is greater than the supply voltage, and coupling a second switch between the second terminal and a voltage which is less than ground.

15 6. The circuit of claim 6 wherein the switching circuit comprises the second switch coupled at a node between the first switch and the voltage which is greater than the supply voltage, and a capacitor coupled to the node,

wherein the first terminal is shunted to the capacitor when decoupling noise from the first terminal.

20 7. The circuit of claim 6 further comprising a programmable pulse generator to generate a pulse that is delayed based on a circuit skew in the circuit, wherein a width of the pulse depends on a duration of a droop of the supply voltage or a spike in the ground voltage.

8. The method of claim 1 further comprising
25 providing another supply voltage to a third terminal of the circuit, wherein the other supply voltage is coupled to a greater voltage to prevent droop in the other supply voltage.

9. The circuit of claim 6 further comprising
30 another supply voltage coupled to a third terminal; and
the ground voltage coupled to a fourth terminal,

wherein actively decoupling noise comprises coupling a third switch between the third terminal and a voltage which is greater than the other supply voltage, and coupling a fourth switch between the fourth

terminal and a voltage which is less than the ground voltage.

10. The circuit of claim 6 wherein the first switch is a first transistor and the second switch is a second transistor, wherein an inverter is coupled to a gate of the first transistor.

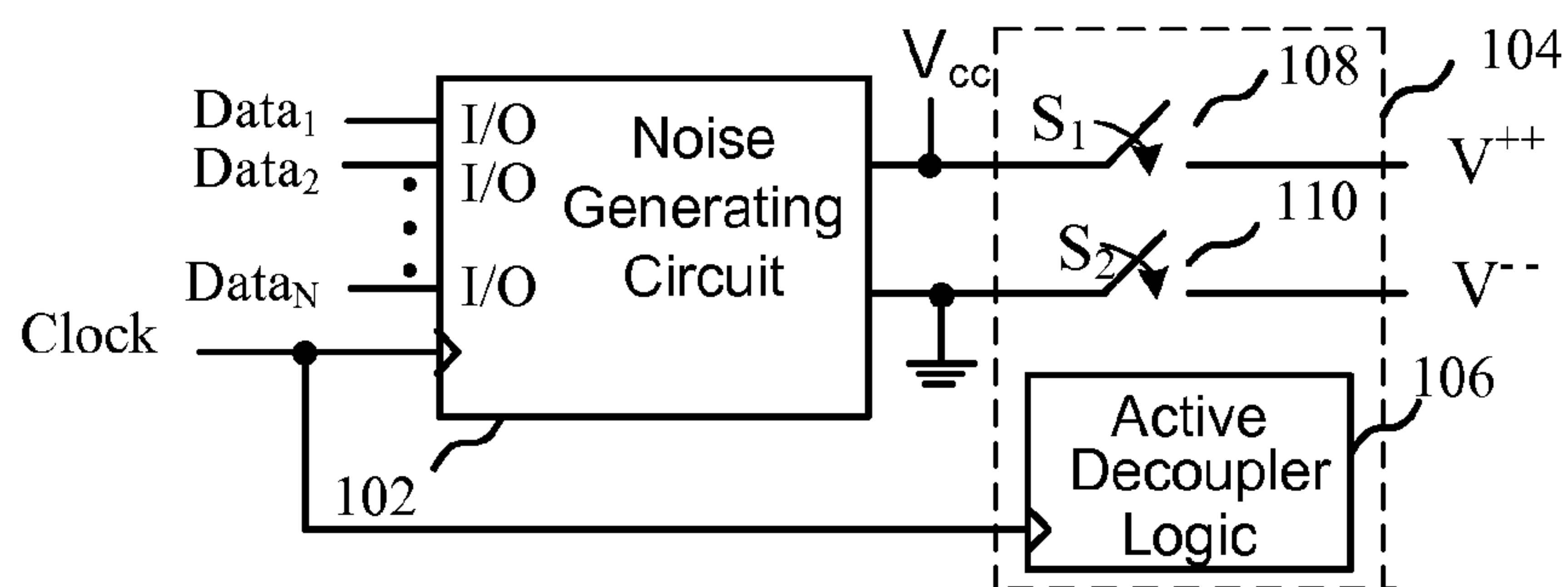


FIG. 1

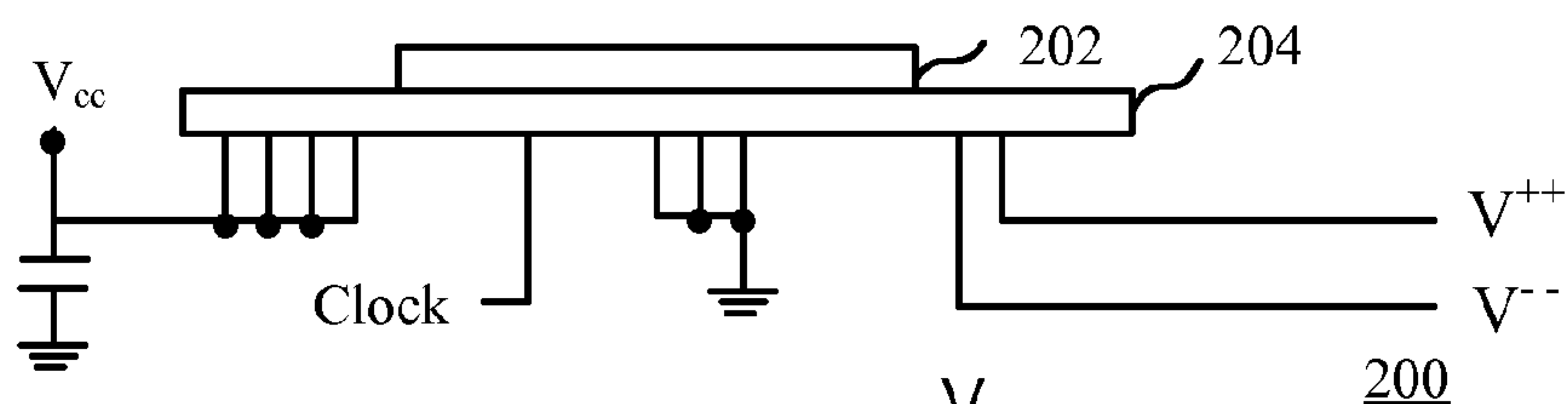


FIG. 2

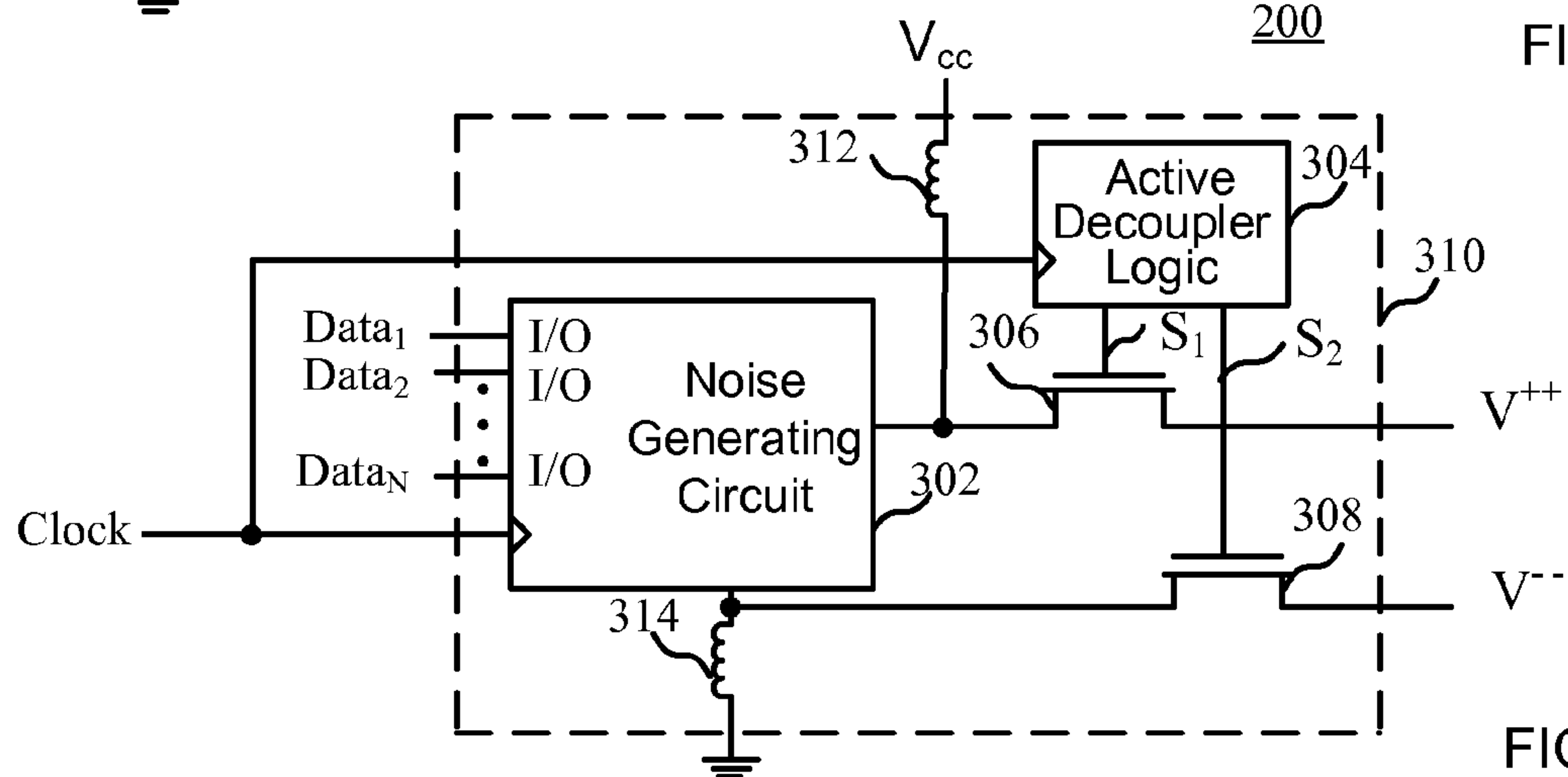


FIG. 3

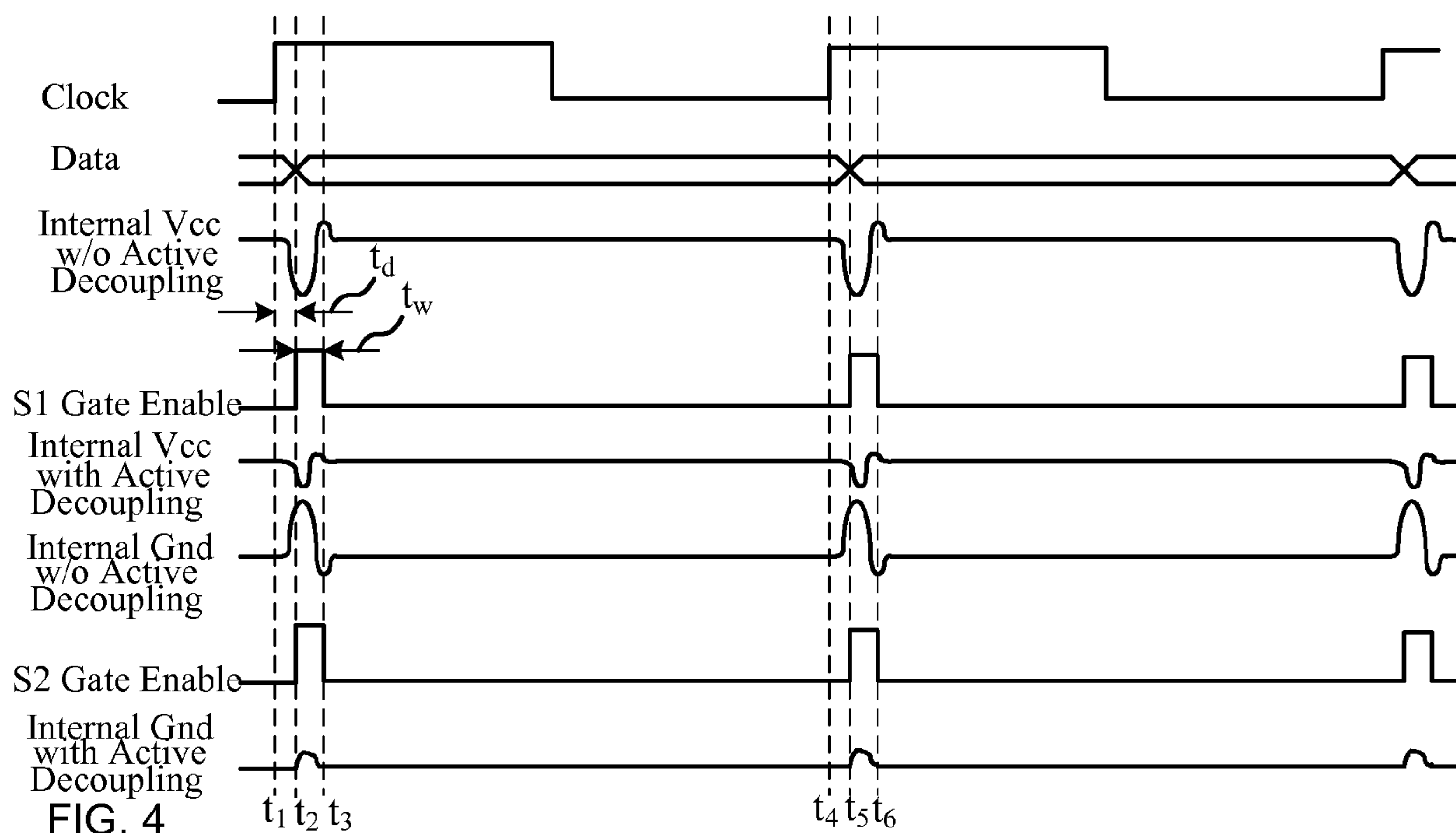


FIG. 4

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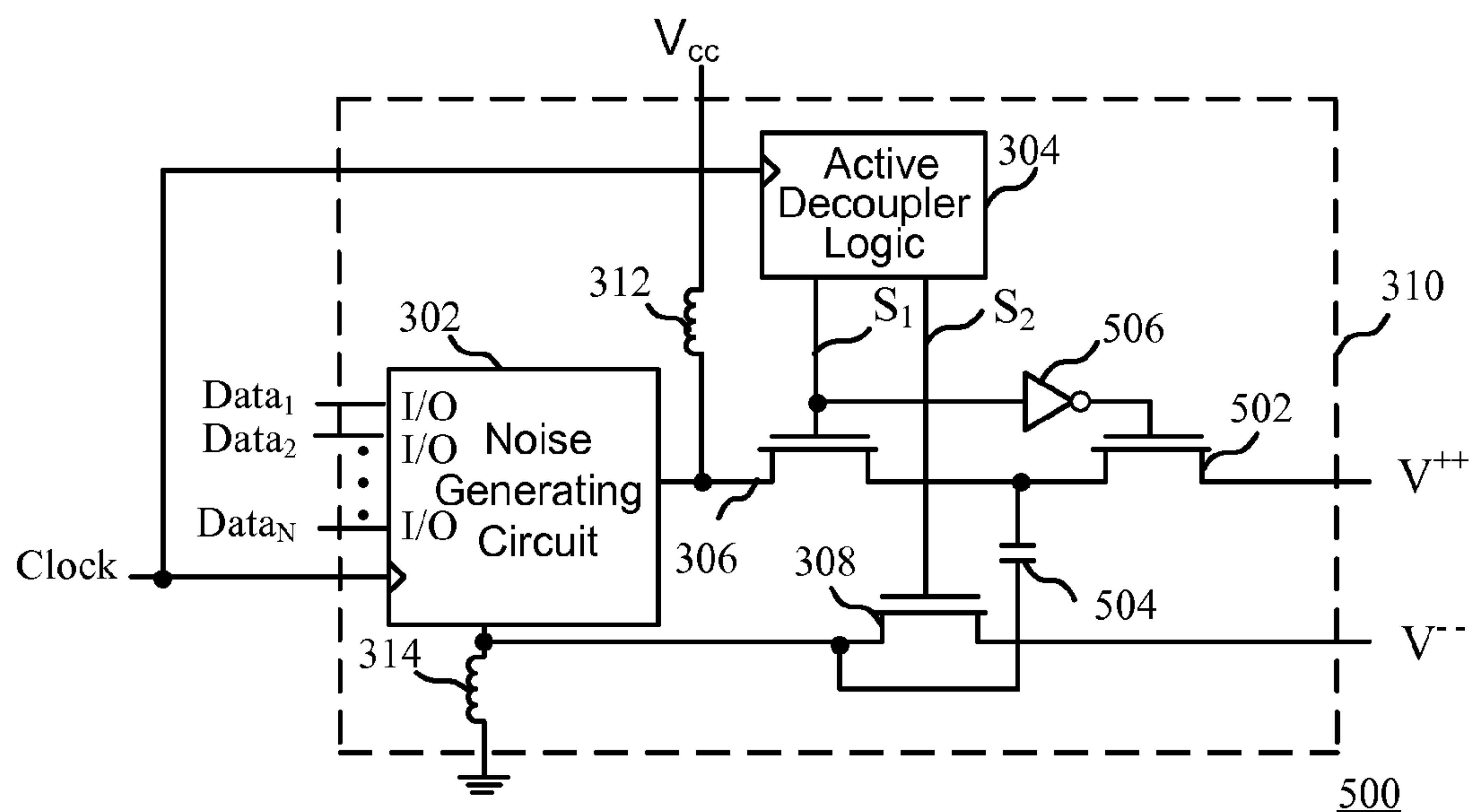


FIG. 5

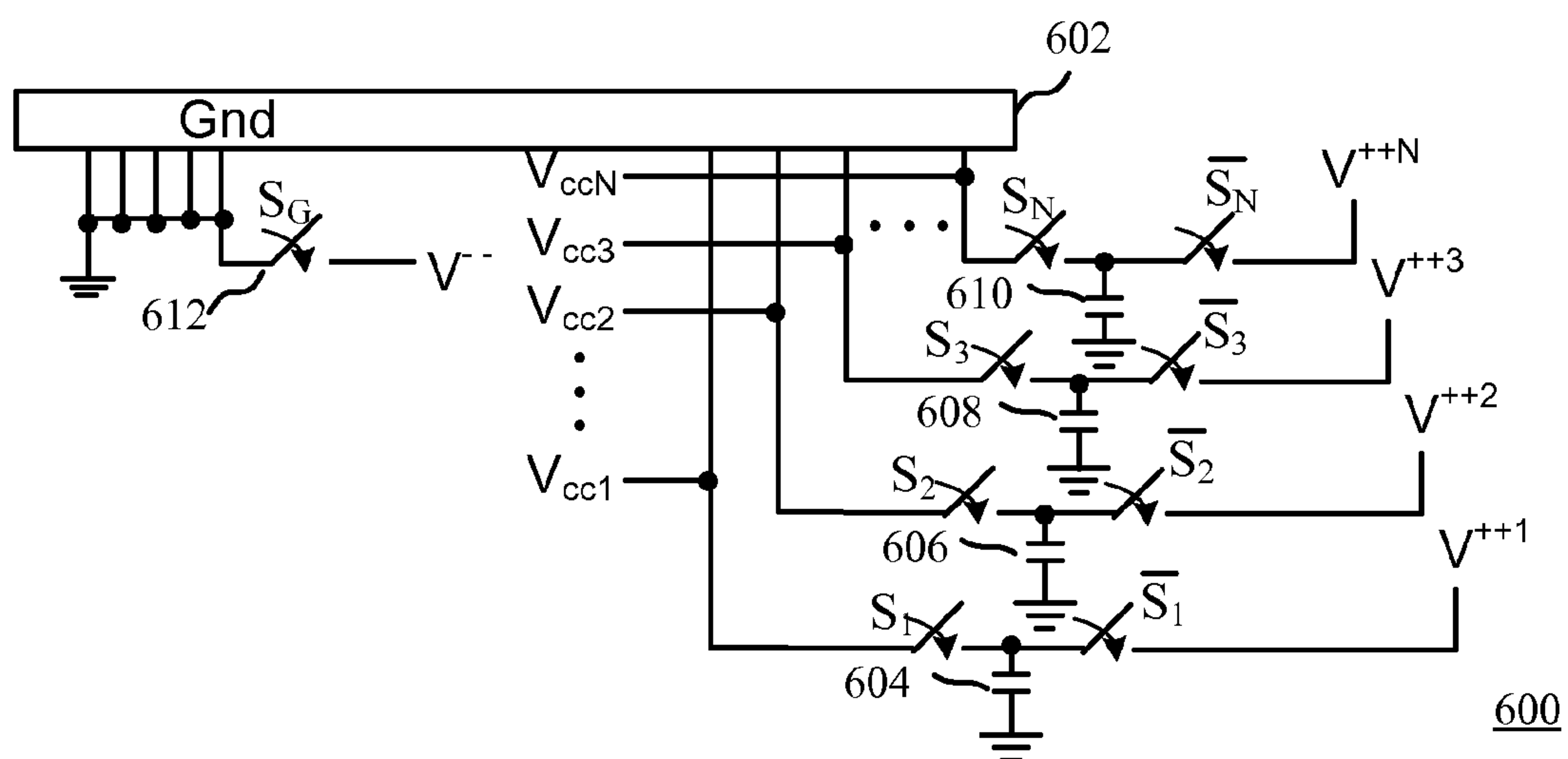


FIG. 6

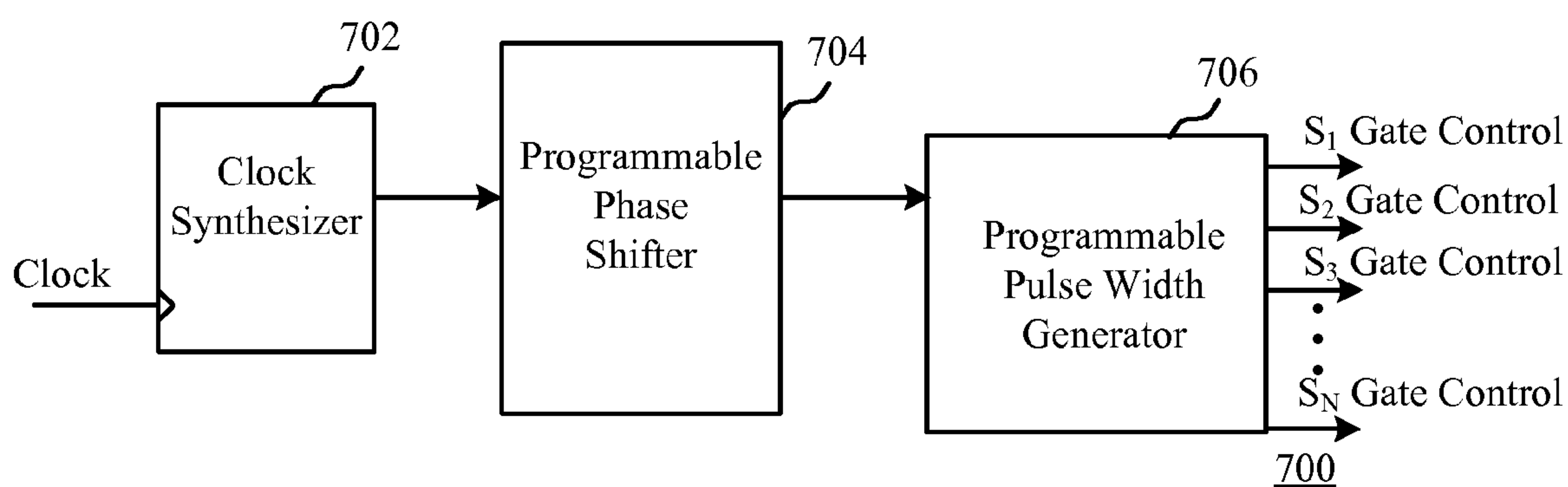


FIG. 7

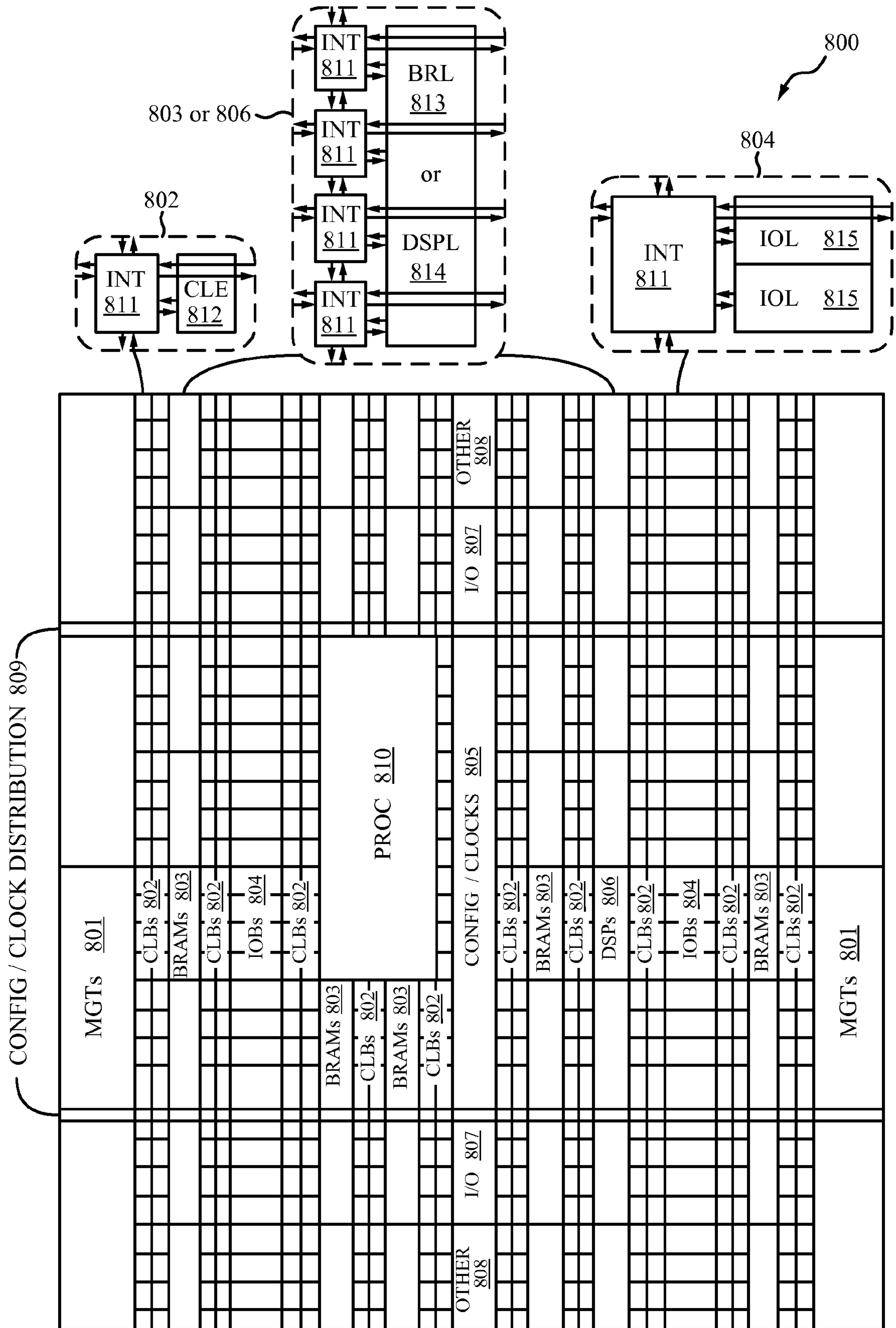


FIG. 8

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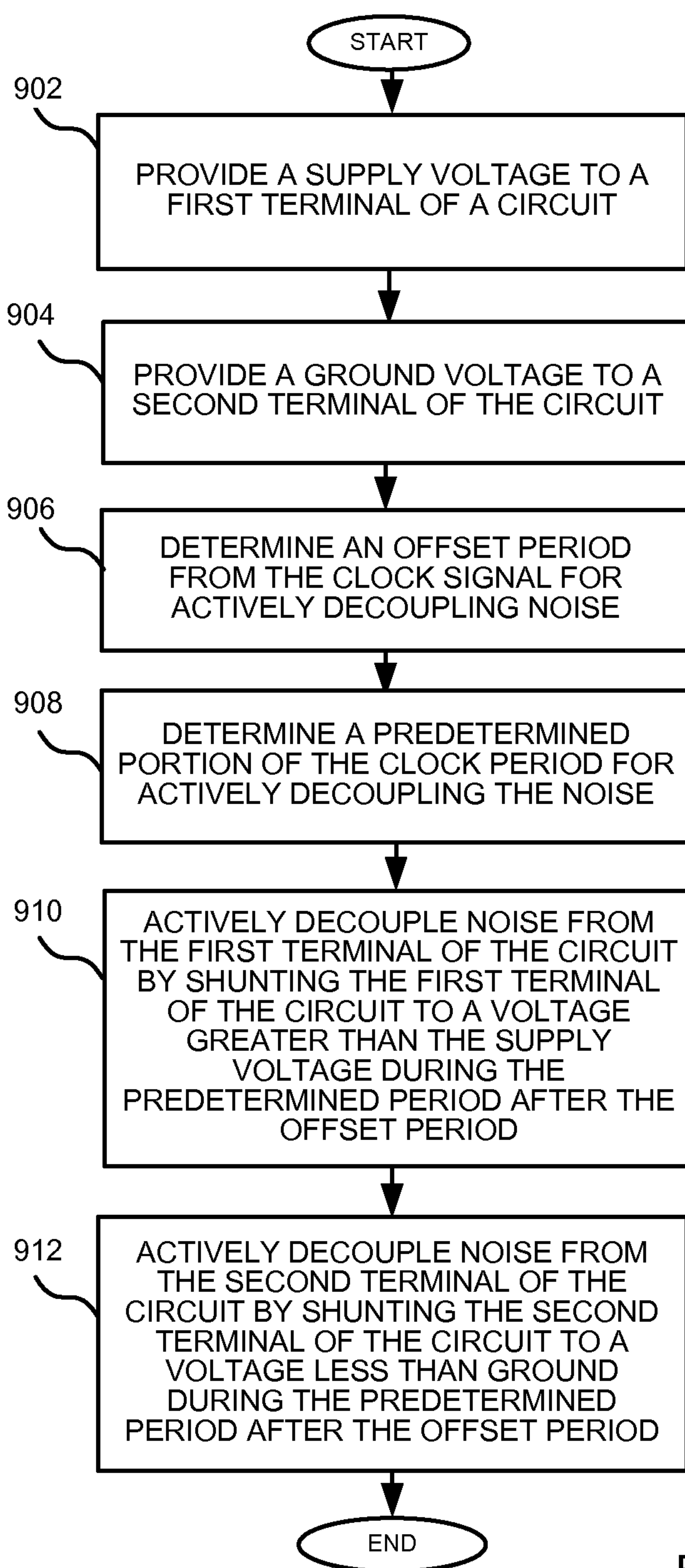


FIG. 9

